

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Tamotsu NISHI et al.

Group Art Unit : Not Yet Assigned

Appl. No. : 10/598,763

Examiner : Not Yet Assigned

(U.S. National Stage of PCT/JP2005/000396)

I.A. Filed : January 14, 2005

Confirmation No. : 9405

For : EQUIPMENT AND METHOD FOR REMOVING NITROGEN OXIDE

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
U.S. Patent and Trademark Office  
Customer Service Window, Mail Stop AMENDMENT  
Randolph Building  
401 Dulany Street  
Alexandria, VA 22314

Sir:

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98,

Applicants hereby bring to the attention of the Examiner the following information.

The following documents were cited in an International Search Report with respect to International Patent Application No. PCT/JP2005/000396, of which the present application is the U.S. National Stage Application. A copy of the International Search Report (in English and Japanese) was been filed concurrently with the present application when entering the National Stage, and should thus have been brought to the attention of the Examiner.

- (1) Japanese Laid-Open Patent Publication No. 2001-129345 A, together with an English language Abstract thereof;
- (2) Japanese Laid-Open Patent Publication No. 2002-153724 A, together with an English language Abstract thereof;
- (3) Japanese Laid-Open Patent Publication No. SHO 53-077871 A, together with an English language Abstract thereof;
- (4) Japanese Laid-Open Patent Publication No. SHO 55-162331 A, together with an English language Abstract thereof;
- (5) Japanese Laid-Open Patent Publication No. 2002-253926 A, together with an English language Abstract thereof;
- (6) Japanese Laid-Open Patent Publication No. 2000-15058 A, together with an English language Abstract thereof;
- (7) Japanese Laid-Open Patent Publication No. HEI 9-253452 A, together with an English language Abstract thereof, and along with English language family member European Patent Publication No. EP 0 798 143 A1;
- (8) Japanese Laid-Open Patent Publication No. HEI 01-296000 A, together with an English language Abstract thereof;
- (9) Japanese Laid-Open Patent Publication No. HEI 11-262629 A, together with an English language Abstract thereof; and
- (10) Japanese Laid-Open Patent Publication No. SHO 51-148675 A, together with an English language Abstract thereof.

The relevance of the documents cited in the International Search Report, as ascertained with respect to the International claims by the International Examiner, is set forth in the International Search Report.

Applicants further bring to the attention of the Examiner the following documents:

- (11) Japanese Laid-Open Patent Publication No. HEI 10-211427 A, together with an English language Abstract of the same;
- (12) Japanese Laid-Open Patent Publication No. HEI 11-009957 A, together with an English language Abstract of the same; and
- (13) Japanese Laid-Open Patent Publication No. 2001-259798 A, together with an English language Abstract of the same.

Applicants note that above-noted documents (11) – (13) are cited on page 4 of the specification of the above-captioned application.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of above-noted documents are attached hereto, and all of the above-noted documents are listed on an attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

Applicant notes that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material. However, if an Office Action on the merits has issued and is crossing this statement in the mail, the undersigned hereby authorizes the Commissioner to charge any fee

necessary for the consideration of this statement, including any payment under 37 C.F.R. §1.17 (p) to Deposit Account No. 19-0089.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,  
Tamotsu NISHI et al.



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January 8, 2007  
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FORM PTO-1449

U.S. Department of Commerce  
Patent and Trademark OfficeAtty. Docket  
P28641Application No.  
10/598,763INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT

(Use several sheets if necessary)

Applicant  
Tamotsu NISHI et al.I.A. Filing Date  
January 14, 2005Group  
Not Yet Assigned

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	2001	- 1 2 9 3 4 5	05/15/01	JAPAN				
	2002	- 1 5 3 7 2 4	05/28/02	JAPAN				
	53	- 0 7 7 8 7 1	07/10/78	JAPAN				
	55	- 1 6 2 3 3 1	12/17/80	JAPAN				
	2002	- 2 5 3 9 2 6	09/10/02	JAPAN				
	2000	- 0 1 5 0 5 8	01/18/00	JAPAN				
	9	- 2 5 3 4 5 2	09/30/97	JAPAN				
		0 7 9 8 1 4 3	10/01/97	E.P.O.				
	1	- 2 9 6 0 0 0	11/29/89	JAPAN				
	11	- 2 6 2 6 2 9	09/28/99	JAPAN				
	51	- 1 4 8 6 7 5	12/12/76	JAPAN				
	10	- 2 1 1 2 4 7	08/11/98	JAPAN				
	11	- 0 0 9 9 5 7	01/19/99	JAPAN				
	2001	- 2 5 9 7 9 8	09/25/01	JAPAN				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	1	English Language Abstract of JP 2001-129345.
	2	English Language Abstract of JP 2002-153724.
	3	English Language Abstract of JP 53-077871.
	4	English Language Abstract of JP 55-162331.
	5	English Language Abstract of JP 2002-253926.
	6	English Language Abstract of JP 2000-015058.
	7	English Language Abstract of JP 9-253452.
	8	English Language Abstract of JP 1-296000.
	9	English Language Abstract of JP 11-262629.
	10	English Language Abstract of JP 51-148675.
	11	English Language Abstract of JP 10-211247.
	12	English Language Abstract of JP 11-009957.
	13	English Language Abstract of JP 2001-259798.

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered.  
Include copy of this form with next communication to applicant.